

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
		Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,866,445	02-1999	Baumann, Robert C.	438/199
	B	US-4,356,623	11-1982	Hunter, William R.	438/305
	C	US-5,208,472	05-1993	Su et al.	257/344
	D	US-4,949,136	08-1990	Jain, Faquir C.	257/344
	E	US-5,851,866	12-1998	Son, Jeong-Hwan	438/231
	F	US-5,759,901	06-1998	Loh et al.	438/305
	G	US-6,034,416	03-2000	Uehara et al.	257/623
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.